

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination HWANG ET AL.	
		Examiner Leith A. Al-Nazer	Art Unit 2821	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0242289	12-2004	Jellicoe et al.	455/575.1
*	B	US-2003/0096583	05-2003	Watanabe, Hiroshi	455/90
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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